## Notice of References Cited

Application/Control No. 10/552,324	Reexamination	Applicant(s)/Patent Under Reexamination LOIBNER ET AL.	
Examiner	Art Unit		
I YNN BRISTOI	1643	Page 1 of 1	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.